SERIAL NO. 09/973,498 DC4960 A INFORMATION DISCLOSURS Chudhury, et. al. (Use several sheets if necessary) **GROUP** October 9, 2001 1713 SOCUMENTS *EXAMINER FILING DATE CLASS SUBCLASS DOCUMENT NUMBER DATE NAME IF APPROPRIATE INITIAL 4,639,285 1/27/87 Suzuki, et. al. 156 272.6 862 4,753,978 6/28/88 Jensen 524 100 8/23/88 Lee, et. al. 525 4,766,176 9/19/89 329 4,868,096 Nakayama, et. al. 430 4,897,153 1/30/90 Cole, et. al. 156 643 204 192.36 6/12/90 4,933,060 Prohaska, et. al. 100 5,017,654 5/21/91 Togashi, et. al. 525 5/5/92 523 211 5,110,845 Gray, et. al. 9/15/92 357 80 5,148,266 Khandros, et. al. 5,344,467 9/6/94 Huang, et. al. 44 358 5,346,861 9/13/94 437 209 Khandros, et. al. **FOREIGN PATENT DOCUMENTS** TRANSLATION CLASS SUBCLASS DOCUMENT NUMBER DATE COUNTRY YES MAR SOLL STORY 12/20/94 JP 06-346034 Japan (abstract only) JP 2000-73029 3/7/00 Japan (abstract only) 10/12/99 JP 11-277699 Japan (abstract only) 8/15/97 JP 09-214140 Japan (abstract only) 12/17/96 JP 08-335608 Japan (abstract only) OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.) University of California, Los Angeles, Electronic Materials, Eli Yablonovitch, Vol. 9, pages 219-229. Analytical Chemistry, David C. Duffy, et. al., "Rapid Prototyping of Microfluidic Systems in Poly(dimethylsiloxane)" Vol. 70, No. 23, December 1, 1998. **DATE CONSIDERED EXAMINER** EXAMINER Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

EXAMINER

Adhesion '99, Seventh International Conference on Adhesion and Adhesives, Churchill College, Cambridge, UK, September 15-17, 1999, "Adhesion Measurement of Silicone Thin Films," Bhukan Parbhoo and Manoj K. Chaudhury, pages 350 - 356.

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